

T3SP10D/T3SP15D Data Sheet

Time Domain Reflectometers

Debug with Precision

Resolution < 3 mm



Affordable Tools for Precision Debugging

- True Differential TDR up to 15 GHz Best for twisted pair and differential design
- No ground connection required.
- Small Form Factor and Battery Powered Measure and analyze in the lab, factory floor or in the field.
- Measure and analyze everywhere you go without an AC requirement.
- S Parameter S11 Measurements Analyze transmission lines, cable, connectors and adaptors in the frequency domain.
- Precisely and rapidly identify any frequency related signal integrity impairments.
- 35 ps Rise Time (SP15D) 50 ps (SP10D) Achieve less than 3 mm fault resolution (SP15D).
- Precisely locate and identify with high resolution signal integrity artifacts.
- Up to 50,000 points long memory Long TDR record capture with high resolution.
- Characterize up to 40 m long cables with more detailed measurement data.
- Pre-Compliance for Emerging Serial Data Standards USB, BroadR-Reach, HDBaseT.
- Debug serial data standards easily.

Key Specifications

Model	T3SP10D	T3SP15D
Frequency	10 GHz	15 GHz
Measurements	Single-ended TDR, Differential TDR, S-parameter S ₁₁ , Smith Chart	
Rise Time	50 ps	35 ps
Memory	Up to 50,000 points	
Battery Operated (B-models)	Yes	
Dimensions	220 x 210 x 82.5 mm	

T3SP10D: 10 GHZ / T3SP15D: 15 GHZ



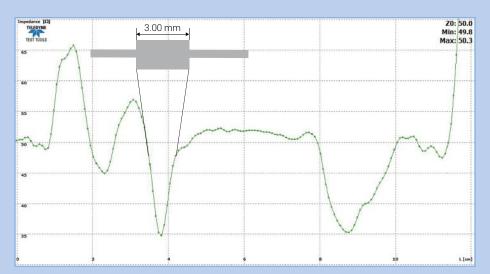
Product Overview

Today's modern fast bus speed designs make debugging signal integrity issues one of the most challenging tasks for engineers to perform efficiently and precisely. For example, take high operating frequencies and mix that with anything that affects your signal's rise time, pulse width, timing, jitter or noise content and you increase the risk of impacting reliability at the system level. If you want to ensure signal integrity you need to understand and control impedance within the transmission environment the signals travel through and the ideal tool to pinpoint those impedance problems are TDR instruments. The Teledyne Test Tools SP-series combines high resolution with a rapid refresh rate, quick data acquisition rate, ultraportable design including a battery option all for a very attractive price. Use it out in the field and in the lab.

Key Benefits

Ultra-Portable and Battery Powered

Current TDR solutions for signal integrity measurements are based on sampling oscilloscopes which are designed to be used in electronics labs. The size and weight of a traditional sampling oscilloscope make it impossible to perform in the field TDR-measurements. The T3SP-series is designed as a portable and lightweight instrument that can easily be used wherever measurements have to be performed. The battery pack option allows up to 3 hours of operation.



OSL calibration in time domain avoid aberrations effects in impedance plots and let the user identify impedance anomalies with less than 3 mm resolution



Based on the true differential design, there is no need for a physical ground connection if differential lanes are measured

True differential TDR

Most of the modern high-speed designs are implemented with differential transmission lines. Using a true differential TDR simplifies the setup for signal integrity measurements in such designs. In some scenarios the ground connection could be difficult to connect or not accessible if you want measure unshielded twisted pair cables. Most of the time, when you take measurements using a true differential TDR a ground connection is not required and gives you the flexibility to use TDR-probes without a ground connection.

Fast TDR Repetition Rate

With up to 10 MHz repetition rate the T3SP-series is more than 300 times faster as conventional TDR-instruments which are based on sampling scopes. To achieve the highest possible dynamic range TDR-instruments need to acquire and average out hundreds of waveforms. The faster sampling rate delivers quicker and more accurate measurement results.

Full Calibrated Impedance Plot

Reference impedance in all TDR instruments are relative; they are made by comparing reflected amplitudes to an incident amplitude. Using full OSL-calibration the T3SP-series is offering best accuracy for impedance measurements in time and frequency domain. Using

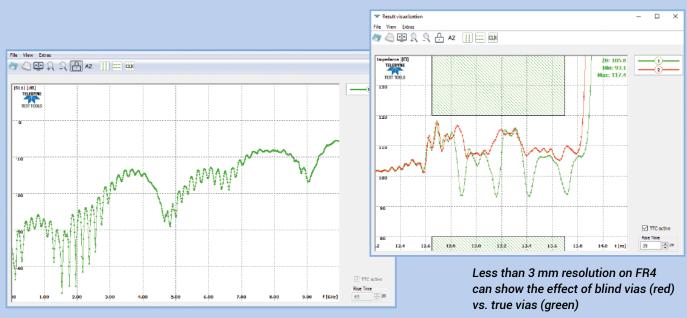
three calibration standards (open, short, load) in the time domain instead of using a simple normalization which is common in TDR-instruments offers vastly improved error correction for the setup. Using OSL calibration in the time domain avoids irregularities in impedance plots, such as ringing that occurs after the TDR incident step.

Full calibrated S-Parameter

Many of the modern standards like Ethernet or USB require you to measure the impedance matching of the cables and connectors within the frequency domain (S-Parameter S11). These are the measures commonly made with traditional VNA instruments. The T3SP-series offers fully calibrated differential S-Parameter measurements up to 15 GHz (T3SP15D) using the same OSLT-calibration standards used by VNAs.

Long memory

The SP-series can acquire up to 50.000 points which gives you a long TDR record capture with high resolution on long DUTs. If the DUT you are going to measure is long, the number of points that can be acquired is limited by the timing resolution of the TDR-plot. Additionally, you have the flexibility to change the TDR repetition rate from 10 MHz to 1MHz using the T3SP-series because it offers you the best timing resolution for cable lengths measuring up to 40 m.



The T3SP1xD series offer S-parameter (S11) measurements up to 15 GHz

ESD-protection

High-frequency measurement devices are extremely sensitive to electrostatic discharge (ESD) and can lead to permanent damage to your measurement device. In addition, many laboratories have a requirement to take special precautions to protect their electronic equipment from any damage caused by ESD. The SP-series mitigates this risk by providing a higher degree of protection from this happening. Every SP-series model comes equipped with an ESD-protection module based on high-performance coaxial RF-switches. The ways this works is the RF input circuitry is protected by isolating the devices RF-signal detector from the input connector when the device is not being used to take measurements.

Measure Impedance and Return Loss

The high bit rates used in modern electronics design and future serial data standards extend well into the microwave region. For example, the High-speed Universal Serial Bus (USB3.1) supports transfer rates up to 10 GB/s over twisted-pair cables. These high bit rate transmissions through connectors and cables results in considerable distortion because of channel dispersion. To keep the distortion to manageable levels, many

standards specify the impedance and return loss for cables and connectors. These measurements are represented by the S-parameter, S11. The T3SP-series offer fully calibrated differential S-Parameter measurements up to 15 GHz (T3SP15D). This gives you the flexibility to store your output files in a variety of formats (CSV, Matlab and Touchstone) which can be easily which can be easily used in tools like SI-Studio, Matlab or other simulation programs.

Controlled Impedance Traces on Printed Circuit Boards (PCB)

Due to increasing clock rates in high speed digital systems the necessity of controlled impedance PCBs is growing rapidly. Additionally, cables and connectors must meet high frequency design specifications and controlled impedance specifications. The T3SP-series helps you to measure wave impedances of PCBs, cables, and connectors very accurate and comfortably. In contrast to other systems on the market, the T3SP-series is designed for measuring specific traces on a PCB and for on-board tests, the TDR-Probes ensure accurate measurement for qualification testing and debugging assembled PCBs.

MODEL SPECIFIC SPECIFICATIONS

Model	T3SP10D	T3SP15D
Operating Frequency	10 GHz	15 GHz
S-parameter Measurements	Single Ended, Differential	
Calibration Method	OSL	
Connector Type	SMA	2.92 mm

Standard Measurement Capability

Measurement Modes	TDR, DTDR
Frequency Domain Displays	S11 (Magnitude, Phase), VSWR, Smith Chart
Time Domain Displays	Oscilloscope Mode, Z – normalized to specified rise time, Step response
File Outputs	CSV, Matlab, Touchstone 1.0, PDF-Report

Pulser / Sampler and Time base

Step Amplitude	150 mV single ended / 300 mV differential (nominal top-base, 50 Ω termination)	
Rise Time	50 ps 35 ps	
	(20 – 80 % typical — as measured by sampler) Rise Time could be limited by software (up to 1 ns)	
Input Voltage Range	+/-325 mV (+/-2 V nondestructive)	
Noise	< 500 μV _{RMS} typical	
Repetition Rate	1, 2, 5, 10 MHz	
Acquisition Duration	50,000 Points	
Max DUT length	40 meters (at 1 MHz sampling rate)	
Equivalent Time Sample Rate	100 GS/s	
Jitter	< 500 fs RMS typical	

Internal ESD Protection Relays

Frequency Rating	>10 GHz	>15 GHz
Rated Life	2 million actuatio	ns per contact

Model	T3SP10D	T3SP15D
Battery (Option)		
Туре	Internal Li-Ion-Battery, 2.2 Ah	
Operational Time	> 3 hours * (in ESD-protection mode)	
Recharging Time	3 hours	

Physical Dimensions

Dimensions	Without connectors: 220 × 210 × 82.5 mm With connectors: 242 × 210 × 82.5 mm Coax connector spacing: 28 mm
Shipping Dimensions	500 mm x 400 mm x 200 mm
Weight	2600 g (2800 g with battery)
Shipping Weight	7300 g (including travel case and accessories)

Power Requirements

Voltage	100 - 240 VAC, 50 - 60 Hz, 1.7 A
	with distributed external power
	adapter
Max. Power Consumption	17 watt (42 watt with battery)

Temperature Range

Operation	0 °C - 40 °C
Store	-20 °C - 80 °C (0 °C - 40 °C with
	Battery)

Recommended PC Configuration

Operating System	Windows 7, Windows 8, Windows 10
Processor	Dual core or better recommended
Memory	Minimal 2 Gbyte
Hard Drive	Minimal 25 Mbyte
Display Resolution	1024 x 768 or larger
Connectivity	USB 2.0

T3SP-DPROBE



The high precision differential TDR Probe T3SP-DPROBE provides an 18 GHz, high performance solution for TDR circuit board impedance characterization and high-speed electrical signal analysis applications. The ergonomic and robust case design providing best ratio of thickness and width. The robust measuring tips guarantee a long life and high repeatability of the measurements.

Parameter	Value / Unit	Comments
Impedance	100 Ω	VSWR < 1.05
Electrical Length	690 ps	
Probe Tips	Fixed Blades	Copper beryllium (3 pairs of replacement tips included)
Pitch	0.1 – 5 mm	adjustable
Pin Configuration	Signal – Signal	
Connectors	SMA female	compatible with 2.92 mm and 3.5 mm connectors
Frequency Range	DC - 18 GHz	valid for probe without tips
Dimensions	130 × 34 × 14 mm	casing only
	157.5 × 34 × 14 mm	with connectors and tips
Material	Aluminum	
Specials		direct in-circuit TDR testing

T3SP-DPROBE-F



The economic differential TDR Probe T3SP-DPROBE provides an ideal solution for TDR circuit board impedance characterization on a very attractive price. It is the ideal probe for fast an accurate PCB impedance measurements up to 5 GHz.

Parameter	Value / Unit	Comments
Impedance	100 Ω	VSWR < 1.05
Electrical Length	830 ps	
Probe Tips	Spring-loaded pin	
Pitch	2.54 mm	fixed
Pin Configuration	Signal – Signal	
Connectors	SMA female	compatible with 2.92 mm and 3.5 mm connectors
Frequency Range	DC - 5 GHz	valid for probe without tips
Dimensions	131 × 32 × 13.2 mm	casing only
	131 × 32 × 15.6 mm	with connectors and tips
Material	Polystyrene	

T3SP-CASE

The TSSP-CASE aluminum case is an ideal choice to safely store and transport your T3SP10D/15D instrument and additional accessories.



Ordering information

Product Description	Product Code
Differential TDR, 50 ps Rise Time, ESD protection, 2 phase matched SMA cables	T3SP10D
Differential TDR, 50 ps Rise Time, ESD protection, 2 phase matched SMA cables, Internal Battery	T3SP10D-B
Differential TDR, 50 ps Rise Time, ESD protection, 2 phase matched SMA cables, SMA Cal. Kit	T3SP10D-BUNDLE
Differential TDR, 50 ps Rise Time, ESD protection, 2 phase matched SMA cables, SMA Cal. Kit, Internal Battery	T3SP10D-B-BUNDLE
Differential TDR, 35 ps Rise Time, ESD protection, 2 phase matched 3.5 mm cables	T3SP15D
Differential TDR, 35 ps Rise Time, ESD protection, 2 phase matched 3.5 mm cables, Internal Battery	T3SP15D-B
Differential TDR, 35 ps Rise Time, ESD protection, 2 phase matched 3.5 mm cables, 3.5 mm Cal. Kit	T3SP15D-BUNDLE
Differential TDR, 35 ps Rise Time, ESD protection, 2 phase matched 3.5 mm cables, 3.5 mm Cal. Kit,	T3SP15D-B-BUNDLE
Internal Battery	
Phase Matched SMA cables (50 ± 1 Ohm, <1 ps skew)	T3SP-CABLE-SMA
Phase Matched 3.5 mm cables (50 ± 1 Ohm, <1 ps skew)	T3SP-CABLE-3.5MM
Differential TDR-Probe (high precision, 18 GHz, 0.5 – 5.0 mm variable pitch)	T3SP-DPROBE
Differential TDR-Probe (economic, 5 GHz, 2.5 or 5 mm fixed pitch)	T3SP-DPROBE-F
OSL Calibration Kit SMA with torque wrench, female	T3SP-CALKIT-SMA
OSL Calibration Kit 3.5MM with torque wrench, female	T3SP-CALKIT-3.5MM
Storage and Travel Case (aluminum suitcase for TDRs and accessories)	T3SP-CASE
Battery Internal Pack – Upgrade	T3SP-B-UPGRADE
Demo and Verification Board	T3SP-BOARD

Platform selection guide

Product Code	Mainframe and phase matched cables	Calibration Kit (Bundle-models)	Internal Battery (B-models)
T3SP10D	Yes	No	No
T3SP10D-B	Yes	No	Yes
T3SP10D-BUNDLE	Yes	Yes	No
T3SP10D-B-BUNDLE	Yes	Yes	Yes
T3SP15D	Yes	No	No
T3SP15D-B	Yes	No	Yes
T3SP15D-BUNDLE	Yes	Yes	No
T3SP15D-B-BUNDLE	Yes	Yes	Yes

ABOUT TELEDYNE TEST TOOLS



Company Profile

Teledyne LeCroy is a leading provider of oscilloscopes, protocol analyzers and related test and measurement solutions that enable companies across a wide range of industries to design and test electronic devices of all types. Since our founding in 1964, we have focused on creating products that improve productivity by helping engineers resolve design issues faster and more effectively. Oscilloscopes are tools used by designers and engineers to measure and analyze complex electronic signals in order to develop high-performance systems and to validate electronic designs in order to improve time to market.

The Teledyne Test Tools brand extends the Teledyne LeCroy product portfolio with a comprehensive range of test equipment solutions. This new range of products delivers a broad range of quality test solutions that enable engineers to rapidly validate product and design and reduce time-to-market. Designers, engineers and educators rely on Teledyne Test Tools solutions to meet their most challenging needs for testing, education and electronics validation.

Location and Facilities

Headquartered in Chestnut Ridge, New York, Teledyne Test Tools and Teledyne LeCroy has sales, service and development subsidiaries in the US and throughout Europe and Asia. Teledyne Test Tools and Teledyne LeCroy products are employed across a wide variety of industries, including semiconductor, computer, consumer electronics, education, military/aerospace, automotive/industrial, and telecommunications.

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